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信息科学与 微电子技术 目录



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说 明

本目录包括三个专业：微电子学、计算机技术和通信技术。其中通信技术专业资料，由中国人民解放军89920部队收藏，其通信地址为：北京市中国人民解放军89920部队。微电子学和计算机技术专业资料，由电子工业部科技情报所收藏，通信地址为北京市750信箱文献馆。如需复制上述资料，可分别与上述两个单位联系。

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